

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 215144US2		SERIAL NO. 09/982,831 NEW APPLICATION		
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Yoshinori HAYASHI, et al.				
				FILING DATE HEREWITH		GROUP 2861		
U.S. PATENT DOCUMENTS								
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE	
b7p	AA	5,570,224	10/29/96	Osamu ENDO, et al.	359	212		
	AB	5,786,594	7/28/98	Tatsuya ITO, et al.	250	236		
	AC	6,081,386	6/27/00	Yoshinori HAYASHI, et al.	359	641		
	AD	6,069,724	5/30/00	Yoshinori HAYASHI, et al.	359	206		
	AE	6,198,562 B1	3/6/01	Yoshinori HAYASHI, et al.	359	204		
	AF	6,185,026 B1	2/6/01	Yoshinori HAYASHI, et al.	359	204		
	AG	5,581,392	12/3/96	Yoshinori HAYASHI	359	205		
	AH	5,557,448	9/17/96	Osamu ENDO, et al.	359	208		
	AI	5,652,670	7/29/97	Yoshinori HAYASHI, et al.	359	205		
	AJ	5,875,051	2/23/99	Seizo SUZUKI, et al.	359	205		
	AK	6,104,522	8/15/00	Yoshinori HAYASHI, et al.	359	207		
	AL	5,986,791	11/16/99	Seizo SUZUKI, et al.	359	207		
	AM	6,239,860 B1	5/29/01	Satoru ITO	355	41		
	AN	6,141,133	10/31/00	Seizo SUZUKI, et al.	359	207		
	AO	6,222,662 B1	4/24/01	Seizo SUZUKI, et al.	359	205		
	FOREIGN PATENT DOCUMENTS							
			DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
b7p	AP	10-246861	9/14/98	Japan (with English Abstract)	—	—	X	
	AQ	11-212009	8/6/99	Japan (with English Abstract)	—	—	X	
	AR							
	AS							
	AT							
	AU							
	AV							
	AW							
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)								
	AX							
	AY							
	AZ							
	AZ							
Examiner <i>Daichi Pham</i>					Date Considered <i>7/16/03</i>			

*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.